

<b>Notice of References Cited</b>	Application/Control No. 10/817,297	Applicant(s)/Patent Under Reexamination BEARMAN ET AL.	
	Examiner Louise N. Leary	Art Unit 1655	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,946,090	08-1999	Tashiro et al.	356/326
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Wokosin et al, IEEE JOURNAL OF SELECTED TOPICS IN QUANTUM ELECTRONICS, VOL. 2, NO. 4, pages 1051-1065, (December 1996).
	V	Wachman et al, APPLIED OPTICS, VOL. 35, NO. 25, pages 5220-5226, (September 1, 1996).
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.